

Search Notes

Application/Control No.

10/729,643

Examiner

David Mis

Applicant(s)/Patent under
Reexamination

SHEN, DAVID H.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
331	1A, 10-12, 14, 16-18, 25	6/6/2005	DM
333	174, 175		
334	11, 14-16		
	78		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR